# ☐ MN101C49 Series

Туре	MN101C49G	MN101C49H	MN101C49K	MN101CF49K	MN101CP49K			
Internal ROM type	Mask ROM			FLASH	EPROM			
ROM (byte)	128K	160K	224K					
RAM (byte)	4K	6K		10K				
Package (Lead-free)	LQFP100-P-1414, QFP100-P-1818B							
Minimum Instruction Execution Time	[Standard] 0.10 μs (at 4.5 V to 5.5 V, 20 MHz) 0.238 μs (at 2.7 V to 5.5 V, 8.39 MHz) 125 μs (at 2.0 V to 5.5 V, 32 kHz)* [Double speed] 0.12 μs (at 4.5 V to 5.5 V, 8.39 MHz) 0.25 μs (at 3.0 V to 5.5 V, 4 MHz) 62.5 μs (at 3.0 V to 5.5 V, 32 kHz)* *: The lower limit for operation guarantee for EPROM built-in type is 2.3 V. The lower limit for operation guarantee for flash memory built-in type is 4.5 V.							

#### ■ Interrupts

RESET. Watchdog. External 0 to 5. Timer 0 to 4. Timer 6. Timer 7 (2 systems). Time base. Serial 0 to 3. Automatic transfer finish. A/D conversion finish. Key interrupts (8 lines)

#### ■ Timer Counter

8-bit timer  $\times$  6

Timer 0 ......Square-wave/8-bit PWM output. Event count. Remote control carrier output. Pulse width measurement

Timer 1 ......Square-wave output. Event count. Synchronous output event

Timer 2 ......Square-wave/8-bit PWM output. Event count. Synchronous output event. Pulse width measurement

Timer 3 ......Square-wave output. Event count. Remote control carrier output

Timer 4 ......Square-wave/8-bit PWM output. Event count. Pulse width measurement. Serial 1 baud rate timer

Timer 6 .....8-bit freerun timer

Timer 0, 1 can be cascade-connected

Timer 2, 3 can be cascade-connected

16-bit timer  $\times$  1

Timer 7 ......Square-wave/16-bit PWM output (cycle/duty continuous variable). Event count. Synchronous output event. Pulse width measurement. Input capture

Time base timer: One-minute count setting

Watchdog timer × 1

#### ■ Serial interface

Synchronous type/UART (full-duplex) × 1: Serial 0

Synchronous type/Simple UART (half-duplex) × 1: Serial 1

Synchronous type  $\times$  1: Serial 2

Synchronous type/Single-master I<sup>2</sup>C × 1: Serial 3

#### ■ DMA controller

Maximum transfer cycles: 255

Starting factor: External request. Various types of interrupt. Software

Transfer mode: 1-byte transfer. Word transfer. Burst transfer

#### ■ I/O Pins

I/O 73: Common use. Specified pull-up resistor available. Input/output selectable (bit unit)

(72): Flash memory built-in type

Input 15: Common use. Specified pull-up resistor available

(14): Flash memory built-in type

#### ■ A/D converter

10-bit  $\times$  8 channels (with S/H)

#### ■ D/A converter

8-bit × 4 channels

#### ■ Special Ports

Buzzer output. Remote control carrier output. High-current drive port

Panasonic MAD00011KEM

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#### ■ ROM Correction

Correcting address designation: Up to 3 addresses possible

### ■ Electrical Charactreistics (Supply current)

Parameter	Symbol	Condition	Limit			Unit
Farameter		Condition		typ	max	UTIIL
Operating supply current	IDD1	fosc = 20  MHz. VDD = 5  V		30	70	mA
	IDD2	fosc = 8.39  MHz. VDD = 5  V		15	30	mA
	IDD3	fx = 32.768  kHz. VDD = 3  V		40	120	μΑ
Supply current at HALT	IDD4	fx = 32 kHz. VDD = 3 V (5 V). Ta = 25 °C		5(13)	11(30)	μΑ
	IDD5	fx = 32.768 kHz. VDD = 3 V (5 V). Ta = 85 °C			30(90)	μΑ
Supply current at STOP	IDD6	VDD = 5 V. Ta = 25 °C			3	μΑ
	IDD7	VDD = 5 V. Ta = 85 °C			60	μΑ

Note) (): Flash memory built-in type

## ■ Development tools

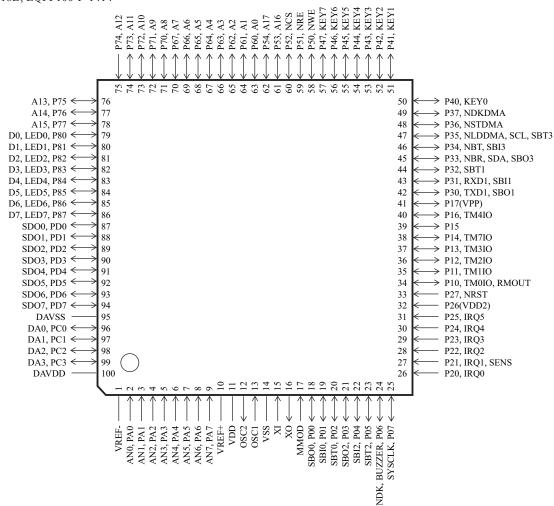
In-circuit Emulator

PX-ICE101C/D + PX-PRB101C49-QFP100-P-1818B

PX-ICE101C/D + PX-PRB101C49-LQFP100-P-1414

#### ■ Pin Assignment

QFP100-P-1818B, LQFP100-P-1414



Note) (): Flash memory built-in type

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